

**Search Notes**

Application/Control No.

10/601,475

Examiner

Elizabeth Ivey

Applicant(s)/Patent under  
Reexamination

KIM ET AL.

Art Unit

1775

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See East Search	1/25/2006	EDI
Consulted Jennifer McNeil, Steve Stein, Tim Speer	1/24/2006	EDI
Updated Search	10/11/2006	EDI